

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/799,503	GAO, YANG	
Examiner Abdelali Serrou		Art Unit 2626		Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,260,010	07-2001	Gao et al.	704/230
*	B US-5,774,837	06-1998	Yeldener et al.	704/208
*	C US-2003/0028373	02-2003	Kandhadai et al.	704/230
*	D US-6,330,533	12-2001	Su et al.	704/220
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I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Serizawa et al. "Joint optimization of LPC and closed-loop pitch parameters in CELP coders", March 1999, Signal Processing Letters, IEEE, Volume 6, pages 52-54.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.